

Search Notes

Application/Control No.

10/524,683

Examiner

Richard Chan

Applicant(s)/Patent under
Reexamination

PARK, YOUNG-TAE

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	550.1	8/14/2006	RC
455	557	8/14/2006	RC
455	556.1	8/14/2006	RC
455	571	8/14/2006	RC
455	572	8/14/2006	RC
455	573	8/14/2006	RC
455	344	8/14/2006	RC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR